Search Notes



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Applicant(s)/Patent Under Reexamination
KAWAKAMI, TAKASHI

Examiner

HENOK G HEYI

Art Unit

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SEARCH	NOTES	

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Searched EAST and consulted Primary Tan Dinh. Some of the subclasses searched are 369/30.03, 30.05, 47.12, 47.13, 83 and 84 (text search only please see search history printout).	05/02/2008	Henok Heyi
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INTERFERENCE SEARCH

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/HENOK G HEYI/ Examiner.Art Unit 2627	

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